Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/669,576	HOCHRAINER ET AL.

Examiner
Teena Mitchell

Art Unit

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Class	Subclass	Date	Examiner
128	200.11 200.14 200.15 200.16	10/13/2007	TKM
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239	411	10/13/07	TKM
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